

認 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			
料號 PART NUMBER	: <u>WAN7020LD</u>	25N04	•	
規格 DESCRIPTION	: Chip Antenna 7	020 M-Ant 2.45G	+5G Type	V
版本 VERSION	: V1.5		X	
日期 ISSUE DATE	: 2023/06/14		KT	
		XX	L `	
	CU	客戶承認 SZOMER APPROVI	ED	
	2	- 10 hr		
		工程部 R&D CENTER		
CIL	承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN	
	Ray	Tennyson	Snow	





萬誠科技股份有限公司

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OneWave Electronic Co., Ltd.

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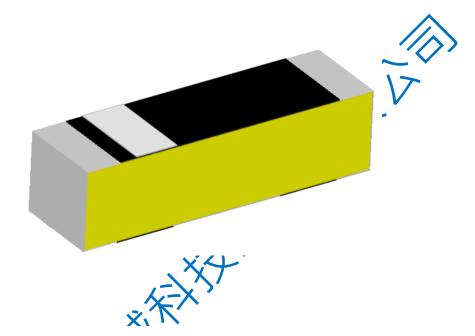
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FAX: +886 2 2898-5055



7020 Chip antenna

For WLAN Dual-Band Applications



P/N: WAN7020LD25N04

	XX	
		Dimension (mm)
10	L	7.00 ± 0.20
	W	2.00 ± 0.20
	Т	1.95 ± 0.20



Part Number Information

WAN

Α	Product Series	Antenna		
В	Dimension L x W	7.0X2.0mm (+-0.2mm)		
С	Material	High K material		
D	Working Frequency	2.4 ~ 2.5GHz + 5.15~5.85GHz		
E	Feeding mode	Monopole & Single Feeding		
F	Antenna type	Type = 04		

1. Electrical Specification

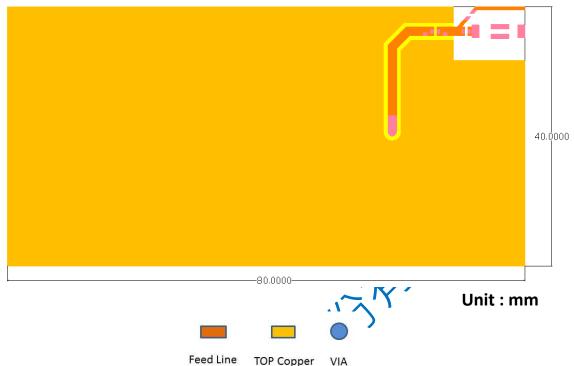
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D	Working Frequency	2.4 ~ 2.5GHz + 5.15~5.85GHz		
E	Feeding mode	Monopole & Single Feeding		
F	Antenna type	Type = 04		
. Electrical Specification				
Specification Part Number WAN7020LD25N04				
	Central Frequency	2450 / 5500	MHz	
	Bandwidth	170 / 800 (Min.)	MHz	
	Return Loss	-10 (Max)	dB	
	Peak Gain	3.98 / 4.63	dBi	
Impedance		50	Ohm	
Ор	erating Temperature	-40~+110	$^{\circ}\! C$	
Maximum Power		4	W	
Resist	ance to Soldering Heats	10 (@ 260°C)	sec.	
A C	Polarization	Linear		
Azimuth Beamwidth Omni-directional				

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



2. Recommended PCB Pattern

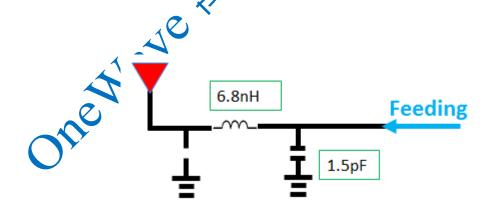
Evaluation Board Dimension



Suggested Matching Circuit

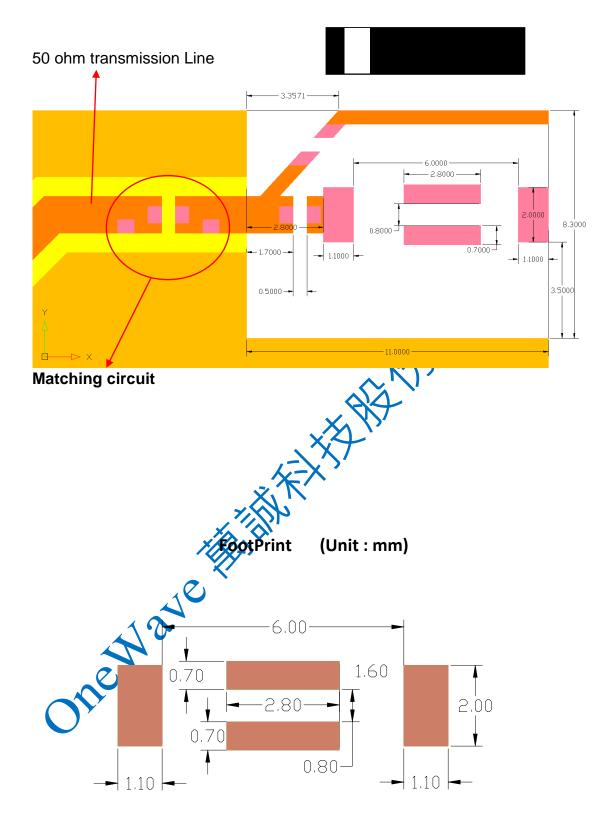
重要資訊:

匹配元件建議使用橋準度高的電感±0.1~0.3nH、電容±0.1pF





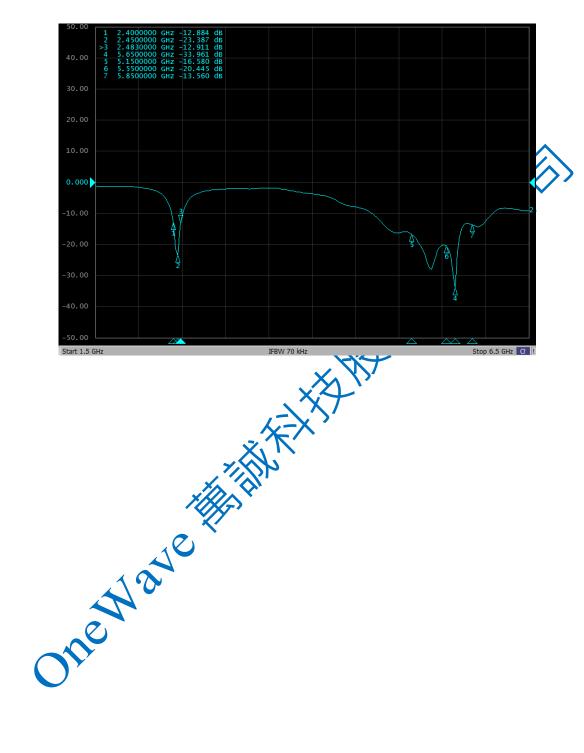
♦ Layout Dimensions in Clearance area (Size=11.0*7.8mm)





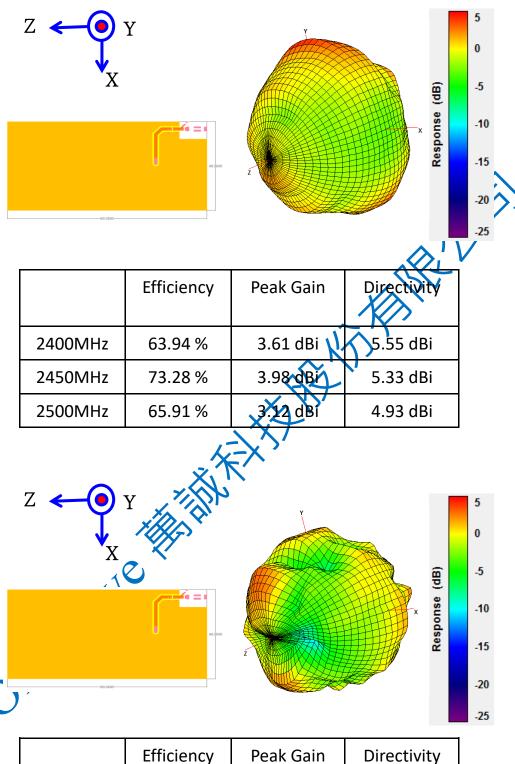
3. Measurement Results

Return Loss





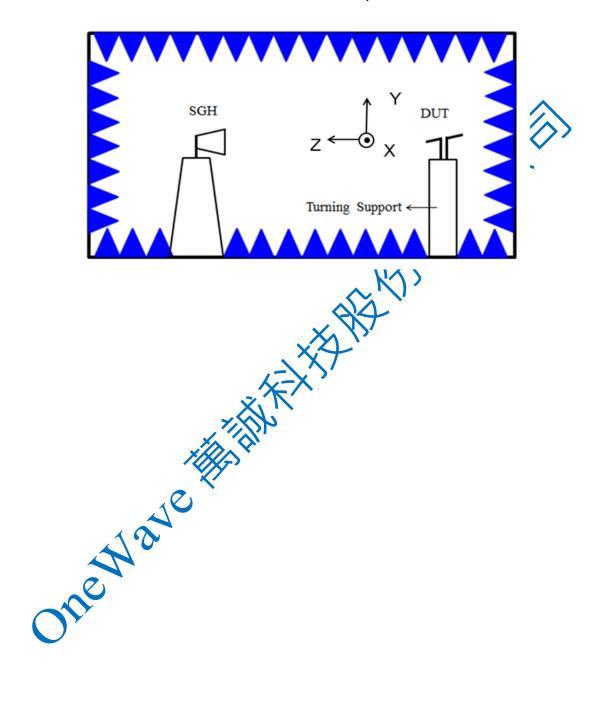
Radiation Pattern



	Efficiency	Peak Gain	Directivity
5150MHz	75.49 %	3.50 dBi	4.72 dBi
5500MHz	62.96 %	4.63 dBi	6.64 dBi
5850MHz	63.88 %	5.02 dBi	6.97 dBi



Chamber Coordinate System





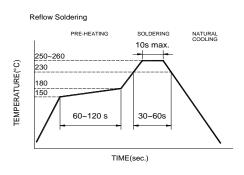
4. Reliability and Test Condictions

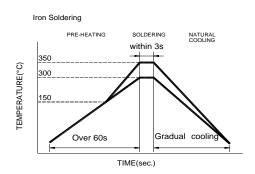
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage	Pre-heating temperature:150°C/60sec.		
	2. No visible mechanical damage	Solder temperature:230±5°C		
	TEMP (℃)	Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5		
	230℃ 4±1 sec.			
	230℃ 4±1 sec.	Flux for lead free: rosin		
	150°C			
	1500			
	60sec			
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C /60sec.		
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C		
	TEMP (℃)	Duration:10±0.5sec.		
	10+0.5.000	Solder:Sn-Ag3.0-Cu0.5		
	260°C	Flux for lead free: rosin		
	150℃			
	60sec \			
Component Adhesion	No visible mechanical damage	The device should be reflow soldered(230±5°C for 10sec.) to a tinned		
(Push test)		copper substrate A dynometer force		
(. 0.0 1001)		gauge should be applied the side of the		
	<u> </u>	component. The device must with-ST-F		
		0.5 Kg without failure of the termination		
Component	No visible mechanical damage	/attached to component.		
Component Adhesion	1. No visible mediamour damage	Insert 10cm wire into the remaining open eye bend ,the ends of even wire lengths		
(Pull test)		upward and wind together.		
(i dii toot)	√-X ,	Terminal shall not be remarkably		
	₹. ★	damaged.		
Thermal shock	No visible mechanical damage	+110°C =>30±3min		
	2. Central Freq. change :within ±6%	-40°C =>30±3min		
	Phase Temperature(°C) Time(min)	Test cycle:10 cycles		
	1 +110±5°C 30±3	The chip shall be stabilized at normal		
	Poom Within	condition for 2~3 hours before		
	Temperature 3sec	measuring.		
	3 -40±2°C 30±3			
	4 Room Within			
	Temperature 3sec			
Resistance to	4 Na visible mash spiral domans	Temperature: +110±5°C		
High	1. No visible mechanical damage	Duration: 1000±12hrs		
Temperature	2. Central Freq. change :within ±6%	The chip shall be stabilized at normal		
	3. No disconnection or short circuit.	condition for 2~3 hours before		
		measuring.		
Resistance to	No visible mechanical damage	Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	No disconnection or short circuit.	The chip shall be stabilized at normal		
	and the second s	condition for 2~3 hours before		
11 12		measuring.		
Humidity	No visible mechanical damage	Temperature: 40±2°C		
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH Duration: 1000±12hrs		
	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		
		mododing		



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

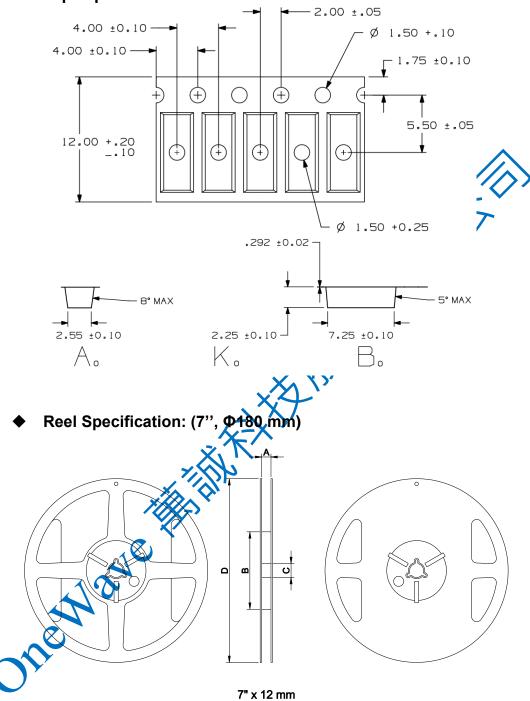
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 wattsoldering iron with tip diameter of 1.0mm
- 280° tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



6.Packaging Information

◆ Tape Specification:



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
12	12±1.0	60±2	13.5±0.5	178±2	2000



7.Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.